## Outline

- Two-Element Interferometer
- Van Cittert-Zernike Theorem
- Aperture Synthesis Imaging

# Cygnus A at 6 cm



## Image courtesy of NRAO/AUI

# Very Large Array (VLA), New Mexico, USA



## Image courtesy of NRAO/AUI

## Two-Element Interferometer

## Fringe Pattern



• for  $I_1 = I_2 = I_0$ 

 $I = 2I_0 \{1 + |\tilde{\gamma}_{12}(\tau)| \cos [\alpha_{12}(\tau) - \phi]\} \quad V = |\tilde{\gamma}_{12}(\tau)|$ 

• source S on central axis, fully coherent waves from two holes

$$I = 2I_0(1 + \cos \phi) = 4I_0 \cos^2 \frac{\phi}{2}$$

## Fringe Pattern (continued)



- distance a between pinholes
- distance s to observation plane Σ<sub>O</sub>, s ≫ a
- path difference  $(r_2 r_1)$  in equation for  $\phi$  in good approximation

$$r_2-r_1 = a\theta = \frac{a}{s}y$$

and therefore

$$I = 4I_0 \cos^2 \frac{\pi a y}{s \overline{\lambda}}$$

## Interference Fringes from Monochromatic Point Source



- irradiance as a function of the *y*-coordinate of the fringes in observation plane Σ<sub>O</sub>
- irradiance vs. distance distribution is Point-Spread Function (PSF) of ideal two-element interferometer
- non-ideal two-element interferometer with finite apertures using pupil function concept (Observational Astrophysics 1)

## **Finite Apertures**

- two circular apertures, diameter *d*, separated by baseline direction vector  $\vec{s}$
- origin of pupil function  $P(\vec{r})$  on baseline vector  $\vec{s}$  symmetrically positioned between apertures
- pupil function using 2-dimensional circular window function Π

$$P(\vec{r}) = \Pi\left(rac{ec{r}-ec{s}/2}{d}
ight) + \Pi\left(rac{ec{r}+ec{s}/2}{d}
ight)$$

• with spatial frequency variable  $\vec{\zeta} = \vec{r}/\lambda$ 

$$\mathcal{P}(\vec{\zeta}) = \Pi\left(rac{ec{\zeta}-ec{s}/2\lambda}{d/\lambda}
ight) + \Pi\left(rac{ec{\zeta}+ec{s}/2\lambda}{d/\lambda}
ight)$$

#### Finite Apertures (continued)

• with  $\vec{\zeta} = \vec{r}/\lambda$ 

$$\mathcal{P}(ec{\zeta}) \,=\, \Pi\left(rac{ec{\zeta}-ec{s}/2\lambda}{d/\lambda}
ight) \,+\, \Pi\left(rac{ec{\zeta}+ec{s}/2\lambda}{d/\lambda}
ight)$$

- length of baseline vector  $|\vec{s}| = D$
- if  $d \ll D$ , pupil function can be approximated by

$$\boldsymbol{P}(\vec{\zeta}) = \delta\left(\vec{\zeta} - \vec{\boldsymbol{s}}/2\lambda\right) + \delta\left(\vec{\zeta} + \vec{\boldsymbol{s}}/2\lambda\right)$$

optical transfer function (OTF) from *self-convolution* of (λ/R)P(ζ)
symmetrical pupil function: autocorrelation of (λ/R)P(ζ):

$$OTF = H_{\lambda}(\vec{\zeta}) = \left(\frac{\lambda}{R}\right)^{2} \int \int_{\text{pupil plane}} P(\vec{\zeta}') P(\vec{\zeta}' - \vec{\zeta}) d\vec{\zeta}'$$

## Finite Apertures (continued)

• pupil function for  $d \ll D$ 

$$\mathcal{P}(ec{\zeta}) \,=\, \delta\left(ec{\zeta} - ec{s}/2\lambda
ight) \,+\, \delta\left(ec{\zeta} + ec{s}/2\lambda
ight)$$

• autocorrelation of  $(\lambda/R)P(\vec{\zeta})$ :

$$\begin{aligned} OTF &= H_{\lambda}(\vec{\zeta}) = \left(\frac{\lambda}{R}\right)^{2} \int \int_{\text{pupil plane}} P(\vec{\zeta}') P(\vec{\zeta}' - \vec{\zeta}) d\vec{\zeta}' \\ &= \left(\frac{\lambda}{R}\right)^{2} \int \int_{\text{pupil plane}} \left[\delta\left(\vec{\zeta}' - \vec{s}/2\lambda\right) + \delta\left(\vec{\zeta}' + \vec{s}/2\lambda\right)\right] \cdot \\ &\cdot \left[\delta\left(\vec{\zeta}' - \vec{\zeta} - \vec{s}/2\lambda\right) + \delta\left(\vec{\zeta}' - \vec{\zeta} + \vec{s}/2\lambda\right)\right] d\vec{\zeta}' \\ &= 2\left(\frac{\lambda}{R}\right)^{2} \left[\delta(\vec{\zeta}) + \frac{1}{2}\delta\left(\vec{\zeta} - \vec{s}/\lambda\right) + \frac{1}{2}\delta\left(\vec{\zeta} + \vec{s}/\lambda\right)\right] \end{aligned}$$

## Finite Apertures (continued)

from before

$$OTF = 2\left(\frac{\lambda}{R}\right)^2 \left[\delta(\vec{\zeta}) + \frac{1}{2}\delta\left(\vec{\zeta} - \vec{s}/\lambda\right) + \frac{1}{2}\delta\left(\vec{\zeta} + \vec{s}/\lambda\right)\right]$$

- pair of pinholes transmits three spatial frequencies
  - DC-component  $\delta(\vec{0})$
  - two high frequencies related to length of baseline vector  $\vec{s}$  at  $\pm \vec{s}/\lambda$
- 3 spatial frequencies represent three-point sampling of the uv-plane in 2-d spatial frequency space
- complete sampling of uv-plane provides sufficient information completely reconstruct original brightness distribution

## Point-Spread Function (PSF)

Optical Transfer Function (OTF) of 2-element interferometer

$$OTF = 2\left(\frac{\lambda}{R}\right)^2 \left[\delta(\vec{\zeta}) + \frac{1}{2}\delta\left(\vec{\zeta} - \vec{s}/\lambda\right) + \frac{1}{2}\delta\left(\vec{\zeta} + \vec{s}/\lambda\right)\right]$$

• PSF is Fourier Transform of  $H_{\lambda}(\vec{\zeta})$ 

$$\begin{split} \delta(\vec{\zeta}) &\Leftrightarrow \mathbf{1} \\ \delta\left(\vec{\zeta} - \vec{s}/\lambda\right) &\Leftrightarrow \mathbf{e}^{i2\pi\vec{\theta} \cdot \vec{s}/\lambda} \\ \delta\left(\vec{\zeta} + \vec{s}/\lambda\right) &\Leftrightarrow \mathbf{e}^{-i2\pi\vec{\theta} \cdot \vec{s}/\lambda} \end{split}$$

Point-Spread Function of 2-element interferometer

$$\left(\frac{\lambda}{R}\right)^2 \left[2(1+\cos 2\pi\vec{\theta}\cdot\vec{s}/\lambda)\right] = 4\left(\frac{\lambda}{R}\right)^2 \cos^2\pi\vec{\theta}\cdot\vec{s}/\lambda$$

- $\vec{\theta}$ : 2-d angular coordinate vector
- attenuation factor ()  $P^{2}$  from opherical expansion

## Point-Spread Function (continued)

from before

$$\mathsf{PSF} = \mathsf{4}\left(rac{\lambda}{R}
ight)^2 \cos^2 \pi ec{ heta} \cdot ec{m{s}}/\lambda$$

flux *I*<sub>0</sub> from each pinhole ⇒ brightness distribution for diffracted beam

$$I = 4I_0 \cos^2 \pi \vec{\theta} \cdot \vec{s} / \lambda$$

compare to previous result

$$I = 4I_0 \cos^2 \frac{\pi a y}{s \overline{\lambda}}$$

• the same but now in 2-d setting with  $\vec{\theta}$  replacing y/s and  $\vec{s}$  replacing pinhole distance a

### Interpretation of fringe pattern

flux *I*<sub>0</sub> from each pinhole ⇒ brightness distribution for diffracted beam

$$I = 4I_0 \cos^2 \pi \vec{ heta} \cdot \vec{ heta} / \lambda$$

full constructive interference for

$$I = 4I_0 ext{ for } rac{ec{ heta} \cdot ec{ extbf{s}}}{\lambda} = n (= 0, \pm 1, \pm 2, \ldots) \ o \ |ec{ heta}| = rac{n\lambda}{|ec{ extbf{s}}|\cos ec{ heta}|}$$

full destructive interference for

$$I = 0 \text{ for } \frac{\vec{\theta} \cdot \vec{s}}{\lambda} = (n + \frac{1}{2}) \left( = \pm \frac{1}{2}, \pm \frac{3}{2}, \ldots \right) \quad \rightarrow \quad |\vec{\theta}| = \frac{(n + \frac{1}{2})\lambda}{|\vec{s}|\cos\phi}$$

•  $\cos \phi$  is angle between  $\vec{\theta}$  and baseline vector  $\vec{s}$ 

## Interpretation of fringe pattern (continued)

- PSF represents *corrugated sheet* with modulation along direction of baseline vector  $\vec{s}$  and periodicity  $(\Delta \theta)_s = \lambda/|\vec{s}|$
- PSF is pattern of alternating bright and dark *stripes* orthogonal to direction of baseline vector  $\vec{s}$
- aperture have finite size, diffracted light from apertures is localized, i.e. *d* < *S*, but approximation by δ-functions no longer holds

## Finite Apertures: PSF

 PSF (amplitude squared of diffracted field) from Fourier transformation of pupil function

$$ilde{a}(ec{ heta}) \, \Leftrightarrow \, rac{\lambda}{R} \left[ \Pi \left\{ rac{\lambda}{d} \left( ec{\zeta} - rac{ec{s}}{2\lambda} 
ight) 
ight\} \, + \, \Pi \left\{ rac{\lambda}{d} \left( ec{\zeta} + rac{ec{s}}{2\lambda} 
ight) 
ight\} 
ight]$$

• shift and scale theorems of Fourier theory: if  $f(x) \Leftrightarrow F(s)$ , then  $f[a(x-b)] \Leftrightarrow (e^{-2\pi i b s}/a) F(s/a)$ 

amplitude of diffracted field

$$\begin{split} \tilde{a}(|\vec{\theta}|) &= \left(\frac{\lambda}{R}\right) \left[\frac{1}{4}\pi \left(d/\lambda\right)^{2}\right] \left[\frac{2J_{1}(\pi|\vec{\theta}|d/\lambda)}{\pi|\vec{\theta}|d/\lambda}\right] \left(e^{-2\pi i\vec{\theta}\cdot\vec{s}/2\lambda} + e^{2\pi i\vec{\theta}\cdot\vec{s}/2\lambda}\right) \\ &= 2\left(\frac{\lambda}{R}\right) \left[\frac{1}{4}\pi \left(d/\lambda\right)^{2}\right] \left[\frac{2J_{1}(|\vec{u}|)}{|\vec{u}|}\right] \cos \vec{u} \cdot \vec{s}/d \quad \vec{u} = \pi \vec{\theta} d/\lambda \\ \\ \mathsf{PSF} &= |\tilde{a}(|\vec{\theta}|)|^{2} = 4\left(\frac{\lambda}{R}\right)^{2} \left[\frac{1}{4}\pi \left(d/\lambda\right)^{2}\right]^{2} \left[\frac{2J_{1}(|\vec{u}|)}{|\vec{u}|}\right]^{2} \cos^{2} \vec{u} \cdot \vec{s}/d \end{split}$$

## Finite Apertures: PSF Interpretation

from before

$$\mathsf{PSF} = |\tilde{a}(|\vec{\theta}|)|^2 = 4\left(\frac{\lambda}{R}\right)^2 \left[\frac{1}{4}\pi \left(\frac{d}{\lambda}\right)^2\right]^2 \left[\frac{2J_1(|\vec{u}|)}{|\vec{u}|}\right]^2 \cos^2{\vec{u}} \cdot \vec{s}/d$$

• full constructive interference for

$$rac{ec{ heta}\cdotec{m{s}}}{\lambda}\,=\,n(=\,0,\pm1,\pm2,\ldots)~
ightarrow~|ec{ heta}|\,=rac{n\lambda}{|ec{m{s}}|\cos\phi}$$

• full destructive interference for

$$rac{ec{ heta}\cdotec{s}}{\lambda}\,=\,(n+rac{1}{2})\,(=\,\pmrac{1}{2},\pmrac{3}{2},\pmrac{5}{2},\ldots)\ o\ ec{ heta}ec{ec{ heta}}ec{ec{ heta}ec{ heta}ec{s}}{ec{ec{ heta}}ec{ heta}ec{s}\phi}$$

•  $\cos \phi$  is angle between  $\vec{\theta}$  and baseline vector  $\vec{s}$ 

## **PSF** Interpretation (continued)

from before

$$\mathsf{PSF} = |\tilde{a}(|\vec{\theta}|)|^2 = 4\left(\frac{\lambda}{R}\right)^2 \left[\frac{1}{4}\pi \left(\frac{d}{\lambda}\right)^2\right]^2 \left[\frac{2J_1(|\vec{u}|)}{|\vec{u}|}\right]^2 \cos^2{\vec{u}} \cdot \vec{s}/d$$

- first two terms give normalisation for  $|\vec{\theta}| = 0$
- other terms represent corrugated 2-d Airy brightness distribution, intensity-modulated along the direction of the baseline vector  $\vec{s}$  with periodicity  $(\Delta \theta)_s = \lambda / |\vec{s}|$
- pattern of alternating bright and dark annuli
- separation determined by  $(\Delta \theta)_d = 1.220\lambda/d, 2.233\lambda/d, 3.238\lambda/d, ...$
- superimposed by fringes orthogonal to direction of baseline vector  $\vec{s}$  at distance  $(\Delta \theta)_s = \lambda / |\vec{s}|$

## 2-d Brightness Distribution



PSF of single circular aperture

PSF of two-element interferometer, aperture diameter d = 25 m, length of baseline vector  $|\vec{s}| = 144$  m

 double beam interference fringes showing modulation effect of diffraction by aperture of a single pinhole



## Modulation Effect of Aperture



- typical one-dimensional cross-section along  $u_y = 0$  of the central part of the interferogram
- visibilities are equal to one, because  $I_{min} = 0$
- |γ˜<sub>12</sub>(τ)| = 1 for all values of τ and any pair of spatial points, if and only if the radiation field is *strictly monochromatic*
- a non-zero radiation field for which |γ
  <sub>12</sub>(τ)| = 0 for all values of τ
  and any pair of spatial points cannot exist in free space

## Van Cittert-Zernike Theorem

## **Basic Approach**



- relates brightness distribution of extended source and phase correlation between two points in radiation field
- extended source S incoherent, quasi-monochromatic
- positions P<sub>1</sub> and P<sub>2</sub> in observers plane Σ

$$\tilde{E}_{1}(t)\tilde{E}_{2}^{*}(t) = \mathbf{E}\{\tilde{E}_{1}(t)\tilde{E}_{2}^{*}(t)\} = \tilde{\Gamma}_{12}(0)$$

#### Basic Approach (continued)

 in observers plane Σ with subscripts 1 and 2 referring to positions P<sub>1</sub> and P<sub>2</sub>

$$ilde{E}_1(t) ilde{E}_2^*(t) = \mathbf{E}\{ ilde{E}_1(t) ilde{E}_2^*(t)\} = ilde{\Gamma}_{12}(0)$$

- if  $\tilde{E}_1$  and  $\tilde{E}_2$  are uncorrelated, then  $|\tilde{\Gamma}_{12}(0)|=0$
- full correlation:  $|\tilde{\gamma}_{12}| \left(= \frac{|\tilde{\Gamma}_{12}(0)|}{\sqrt{l_1 l_2}}\right) = 1$
- partial correlation:  $0 < |\tilde{\gamma}_{12}(0)| < 1$
- extended source is collection of non-coherent infinitesimal sources
- reduction in fringe contrast described by Visibility function V:

$$V = rac{I_{max} - I_{min}}{I_{max} + I_{min}} = | ilde{\gamma}_{12}(0)|$$

## **Overview without Equations**



- relate γ<sub>12</sub>(0) to brightness distribution of extended source S
- source S is quasi-monochromatic, incoherent source in plane σ, intensity distribution *I*(*y*, *z*)
- observation plane  $\Sigma$  parallel to  $\sigma$
- *I* is perpendicular to both planes (coincident with the *X*-axis) connecting center of extended source (*y* = 0, *z* = 0) to zero reference in Σ (*Y* = 0, *Z* = 0).

## Overview without Equations (continued)



- two positions P<sub>1</sub>, P<sub>2</sub>
- describe coherence  $\gamma_{12}(0)$ in plane  $\Sigma$
- infinitesimal radiation element dS in source at distances R<sub>1</sub> and R<sub>2</sub> from P<sub>1</sub> and P<sub>2</sub>
- assume *S* not a source but an aperture of identical size and shape
- assume that *I*(*y*, *z*) is not description of intensity distribution but its functional form corresponds to the *field distribution* across that aperture

## Overview without Equations (continued)



- imagine a transparancy at aperture with amplitude transmission characteristics that correspond functionally to the irradiance distribution I(y, z)
- imagine that aperture is illuminated by spherical wave converging towards fixed point P<sub>2</sub> so that diffraction pattern is centered at P<sub>2</sub>
- this diffracted field distribution, normalised to unity at P<sub>2</sub>, is everywhere (e.g. at P<sub>1</sub>) equal to the value of γ<sub>12</sub>(0) at that point

## Overview with Equations

- in limit R<sub>1</sub>, R<sub>2</sub> much larger than source diameter and relevant part of Σ-plane, equivalent of Fraunhofer diffraction
- almost always satisfied for astronomical observations
- van Cittert-Zernike theorem

$$\tilde{\Gamma}(\vec{r}) = \int \int_{\text{source}} I(\vec{\Omega}) e^{rac{2\pi i \vec{\Omega}. \vec{r}}{\lambda}} d\vec{\Omega}$$

$$I(ec{\Omega}) = \lambda^{-2} \int \int_{\Sigma ext{-plane}} \widetilde{\Gamma}(ec{r}) e^{-rac{2\pi i ec{\Omega}.ec{r}}{\lambda}} dec{r}$$

- *I*(Ω) is intensity distribution of extended source as function of unit direction vector Ω as seen from observation plane Σ
- $\tilde{\Gamma}(\vec{r})$  is coherence function in  $\Sigma$ -plane
- center of extended source S is origin of Ω (coincident with central axis I), small angular extent of source: I(Ω) = I(θ<sub>y</sub>, θ<sub>z</sub>) and dΩ = dθ<sub>y</sub>dθ<sub>z</sub>, where θ<sub>y</sub>, θ<sub>z</sub> two orthogonal angular coordinate axes across the source

## Overview with Equations (continued)

van Cittert-Zernike theorem

$$\widetilde{\Gamma}(\vec{r}) = \int \int_{\text{source}} I(\vec{\Omega}) e^{rac{2\pi i \vec{\Omega}. \vec{r}}{\lambda}} d\vec{\Omega}$$

$$I(ec{\Omega}) = \lambda^{-2} \int \int_{\Sigma ext{-plane}} \widetilde{\Gamma}(ec{r}) e^{-rac{2\pi i ec{\Omega}.ec{r}}{\lambda}} dec{r}$$

- vector  $\vec{r}$  represents arbitrary baseline  $\vec{r}(X, Y)$  in plane with  $d\vec{r} = dYdZ$  (e.g.  $\overline{P_1P_2} = \vec{r}_{P_1} \vec{r}_{P_2}$ )
- Γ(r) and I(Ω) are linked through Fourier transform, except for scaling with wavelength λ
- scaling might be perceived as "true" Fourier transform with conjugate variables Ω and r/λ,
- van Cittert-Zernike theorem as Fourier pair

$$I(\vec{\Omega}) \Leftrightarrow \tilde{\Gamma}(\vec{r}/\lambda)$$

## Overview with Equations (continued)

van Cittert-Zernike theorem

$$ilde{\mathsf{\Gamma}}(ec{r}) = \int \int_{ ext{source}} I(ec{\Omega}) e^{rac{2\pi i ec{\Omega}.ec{r}}{\lambda}} dec{\Omega}$$

$$I(ec{\Omega}) = \lambda^{-2} \int \int_{\Sigma ext{-plane}} \widetilde{\Gamma}(ec{r}) e^{-rac{2\pi i ec{\Omega}.ec{r}}{\lambda}} dec{r}$$

• complex spatial degree of coherence

$$ilde{\gamma}(ec{r}) = rac{ ilde{\Gamma}(ec{r})}{\int\int_{ ext{source}} I(ec{\Omega}) dec{\Omega}}$$

i.e. normalising by total source intensity

 extended source S is spatially incoherent, but partially correlated radiation field at e.g. positions P<sub>1</sub> and P<sub>2</sub> exists since all individual source elements contribute to a specific location P in Σ-plane

#### Derivation of Van Cittert-Zernike Theorem



- observation plane  $\Sigma$ contains baseline vector  $\vec{r}(Y, Z)$  and is perpendicular to vector pointing at centre of radiation source
- angular coordinates  $\theta_y$  and  $\theta_z$  across the source correspond to linear coordinates of unit direction vector  $\vec{\Omega}(\Omega_X, \Omega_Y, \Omega_Z)$ , i.e. direction cosines of  $\vec{\Omega}$  relative to X, Y, Z coordinate system  $(\Omega_X^2 + \Omega_Y^2 + \Omega_Z^2 = 1)$ .



- spatial coherence of *EM*-field between two positions 1 and 2 is outcome of correlator producing  $\mathbf{E} \left\{ \tilde{E}_1(t) \tilde{E}_2^*(t) \right\}$
- positions 1, 2 not point like, represent *radio antennae* or *optical telescopes*
- if *I*(Ω) = *I*<sub>0</sub>δ(Ω), i.e. a point source on the *X*-axis, the Van Cittert-Zernike relation yields |Γ̃(*r*)| = *I*<sub>0</sub> and |γ̃(*r*)| = 1: a plane wave simultaneously hits entire *YZ*-plane, full coherence is preserved



- infinitesimal source element in direction  $\vec{\Omega}_0 \Longrightarrow l_0 \delta(\vec{\Omega} - \vec{\Omega}_0)$ projection of  $\vec{\Omega}_0$  on the  $\Sigma$ -plane is  $\vec{\Omega}'_0(\Omega_Y, \Omega_Z)$
- difference in path length between positions 1 and 2 given by projection of  $\vec{r}$  on  $\vec{\Omega}_0$ , i.e.  $\vec{r}.\vec{\Omega}'_0 = \Omega_Y Y + \Omega_Z Z$
- therefore

$$\begin{split} \tilde{E}_{1}(t) &= \tilde{E}_{0}(t)e^{2\pi i\nu_{0}\left(t+\frac{\vec{\Omega}_{0}.\vec{r}}{c}\right)} \\ &= \tilde{E}_{0}(t)e^{\left(2\pi i\nu_{0}t+\frac{2\pi i\vec{\Omega}_{0}.\vec{r}}{\lambda}\right)} \\ \tilde{E}_{2}^{*}(t) &= \tilde{E}_{0}(t)e^{-2\pi i\nu_{0}t} \end{split}$$

$$\begin{split} \tilde{E}_{1}(t) &= \tilde{E}_{0}(t) e^{2\pi i \nu_{0} \left(t + \frac{\vec{\Omega}_{0}, \vec{r}}{c}\right)} \\ &= \tilde{E}_{0}(t) e^{\left(2\pi i \nu_{0} t + \frac{2\pi i \vec{\Omega}_{0}, \vec{r}}{\lambda}\right)} \\ \tilde{E}_{2}^{*}(t) &= \tilde{E}_{0}(t) e^{-2\pi i \nu_{0} t} \end{split}$$

• 
$$\mathbf{E}\left\{\tilde{E}_{1}(t)\tilde{E}_{2}^{*}(t)\right\} = \mathbf{E}\left\{|\tilde{E}_{0}(t)|^{2}\right\}e^{\frac{2\pi i\vec{\Omega}_{0}.\vec{t}}{\lambda}} = I_{0}(\vec{\Omega}_{0})e^{\frac{2\pi i\vec{\Omega}_{0}.\vec{t}}{\lambda}}$$

 integration over full source extent (all source elements are spatially uncorrelated)

$$ilde{\Gamma}(ec{r}) = \int \int_{ ext{source}} I_0(ec{\Omega}) e^{2\pi i ec{\Omega}.ec{r}/\lambda} dec{\Omega}$$

$$ilde{\gamma}(ec{r}) = rac{\int \int_{ ext{source}} I_0(ec{\Omega}) e^{2\pi i ec{\Omega}. ec{r}/\lambda} dec{\Omega}}{\int \int_{ ext{source}} I_0(ec{\Omega}) dec{\Omega}}$$

coherence

$$ilde{\Gamma}(ec{r}) = \int \int_{ ext{source}} I_0(ec{\Omega}) e^{2\pi i ec{\Omega}.ec{r}/\lambda} dec{\Omega}$$

- Γ(*r*) at a certain point represents a *single* Fourier component (with baseline *r*) of the intensity distribution of the source with strength Γ(*r*)*dr*
- short baseline (small  $|\vec{r}|$ ) corresponds to low spatial frequency component in brightness distribution  $I(\theta_y, \theta_z)$ , i.e. *coarse* structure
- large values of  $|\vec{r}|$  correspond to *fine* structure in  $I(\theta_y, \theta_z)$
- diffraction limited resolution in aperture synthesis is

$$|ec{r}_{max}| = L_{max} \Longrightarrow heta_{min} = rac{\lambda}{2L_{max}}$$

• factor 2 in denominator of expression for  $\theta_{min}$  follows from rotation symmetry in aperture synthesis

## Example: Uniform Slit



- coherence function γ
  <sub>12</sub>(0) for uniform slit source
- slit width b, running coordinate ξ, observation plane Σ, running coordinate y, located at large distance / from slit source (Fraunhofer limit)

#### Example: Uniform Slit (continued)



- source function is window function  $\Pi\left(\frac{\xi}{b}\right)$
- in angular equivalent  $\Pi\left(\frac{\beta}{\beta_0}\right)$ , with  $\beta_0 = b/I$
- application of Van Cittert-Zernike theorem  $I(\vec{\Omega}) \Leftrightarrow \tilde{\Gamma}(\vec{r}/\lambda)$ :

$$\Pi\left(\frac{\beta}{\beta_0}\right) \Leftrightarrow \beta_0 \operatorname{sinc}\left(\frac{y\beta_0}{\lambda}\right) = \beta_0 \operatorname{sinc}\left(\frac{yb}{\lambda I}\right)$$

 $\operatorname{sinc}(x) = \left(\frac{\sin \pi x}{\pi x}\right)$ 

#### Example: Uniform Slit (continued)

• from Van Cittert-Zernike theorem  $I(\vec{\Omega}) \Leftrightarrow \tilde{\Gamma}(\vec{r}/\lambda)$ :

$$\Pi\left(\frac{\beta}{\beta_0}\right) \Leftrightarrow \beta_0 \operatorname{sinc}\left(\frac{\gamma\beta_0}{\lambda}\right) = \beta_0 \operatorname{sinc}\left(\frac{\gamma b}{\lambda l}\right)$$

modulus of normalised complex coherence function

$$|\tilde{\gamma}(\mathbf{y})| = \left| \frac{\beta_0 \operatorname{sinc} \frac{\mathbf{y}\mathbf{b}}{\lambda \mathbf{l}}}{\beta_0} \right| = \left| \operatorname{sinc} \frac{\mathbf{y}\mathbf{b}}{\lambda \mathbf{l}} \right| = \mathbf{V} \Rightarrow \operatorname{Visibility}$$

- enlarging b with a factor shrinks coherence function by same factor
- if brightness structure of radiation source covers wide range of angular scales from Δ down to δ, spatial coherence function shows finest detail of λ/Δ over maximum extent of ≈ λ/δ